P-channel vertical D-MOS logic level FET Rev. 02 — 14 December 2010

Product data sheet

Product profile 1.

1.1 General description

Logic level P-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using vertical D-MOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

1.2 Features and benefits

- Suitable for high frequency applications due to fast switching characteristics
- Suitable for logic level gate drive sources
- Suitable for very low gate drive sources voltage

1.3 Applications

- Battery powered applications
- High-speed digital interfaces

1.4 Quick reference data

Table 1.	Quick reference data					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C	-	-	-16	V
I _D	drain current	T _{sp} = 25 °C	-	-	-4.6 6	А
P _{tot}	total power dissipation		-	-	5	W
Static cha	aracteristics					
R _{DSon}	drain-source on-state	V_{GS} = -2.5 V; I _D = -1 A; T _j = 25 °C	- 117 - 80	150	mΩ	
	resistance	V_{GS} = -4.5 V; I_D = -1 A; T_j = 25 °C		80	120	mΩ
Dynamic	characteristics					
Q_{GD}	gate-drain charge	V_{GS} = -4.5 V; I _D = -1 A; V_{DS} = -10 V; T _j = 25 °C	-	1.83	-	nC



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2. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		_
2	S	source		
3	S	source		
4	G	gate		G↓ŢŢ
5	D	drain		
6	D	drain	SOT96-1 (SO8)	S 001aaa025
7	D	drain		
8	D	drain		

3. Ordering information

Table 3. Ordering in			
Type number	Package		
	Name	Description	Version
PHK04P02T	SO8	plastic small outline package; 8 leads; body width 3.9 mm	SOT96-1

4. Limiting values

Table 4.Limiting values

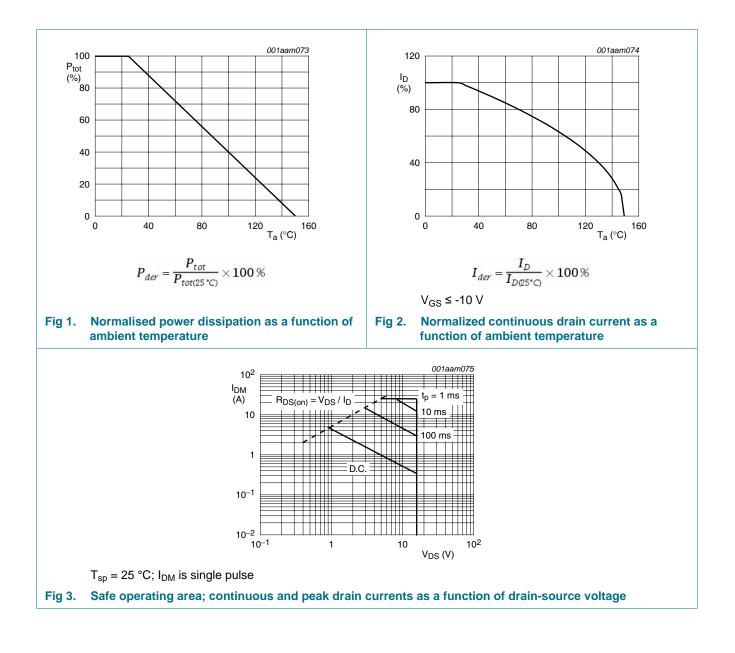
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C	-	-16	V
V _{DGR}	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$	-	-16	V
V _{GS}	gate-source voltage		-8	8	V
I _D	drain current	T _{sp} = 100 °C	-	-1.87	А
		T _{sp} = 25 °C	-	-4.66	А
I _{DM}	peak drain current	T _{sp} = 25 °C; pulsed	-	-26.4	А
P _{tot}	total power dissipation	T _{sp} = 25 °C	-	5	W
		T _{sp} = 100 °C	-	2	W
T _{stg}	storage temperature		-55	150	°C
Tj	junction temperature		-55	150	°C
Source-drai	n diode				
Is	source current	T _{sp} = 25 °C	-	-4.66	А
I _{SM}	peak source current	$T_{sp} = 25 \text{ °C}; \text{ pulsed}; t_p \le 5 \text{ s}$	-	-26	А

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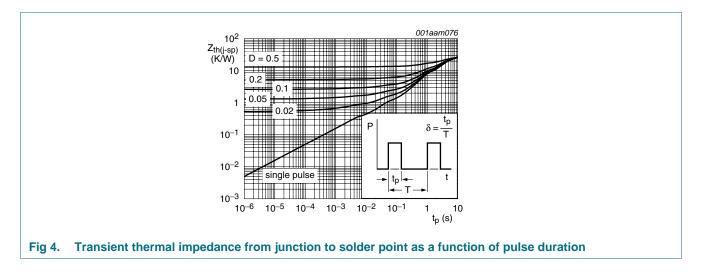
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5. Thermal characteristics

Table 5.	Thermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-sp)}	thermal resistance from junction to solder point	mounted on metal clad substrate	-	25	-	K/W

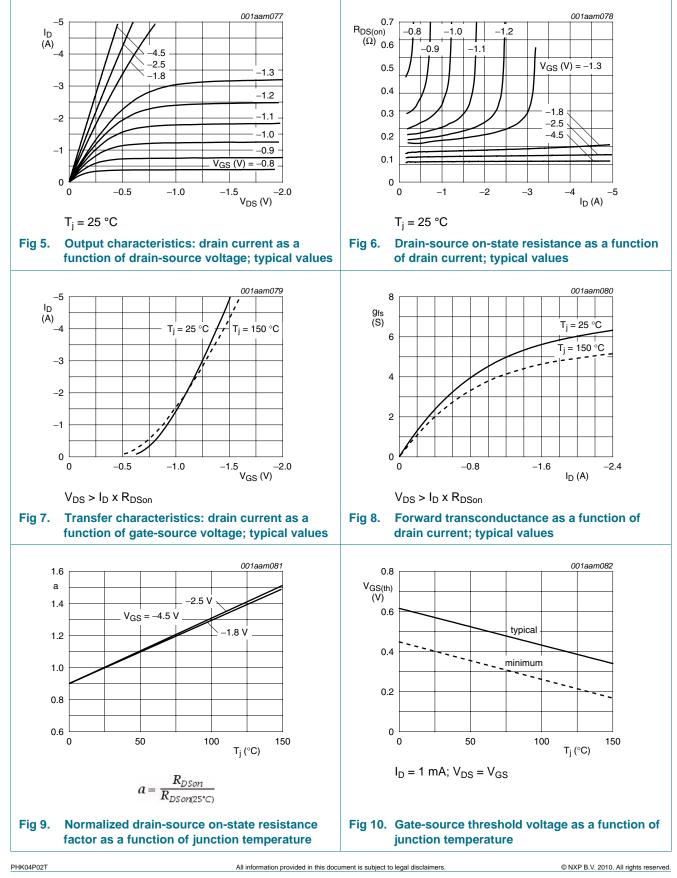


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6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
V _{(BR)DSS}	drain-source breakdown voltage	I_D = -10 µA; V_{GS} = 0 V; T_j = 25 °C	-16	-	-	V
V _{GS(th)}	gate-source threshold voltage	$I_D = -1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C}$	-0.4	-0.6	-	V
		$I_D = -1 \text{ mA}; V_{DS} = V_{GS}; T_j = 150 \text{ °C}$	-0.1	-	-	V
I _{DSS}	drain leakage current	V_{DS} = -13 V; V_{GS} = 0 V; T_j = 25 °C	-	-50	-100	nA
		V_{DS} = -13 V; V_{GS} = 0 V; T_j = 150 °C	-	-13	-100	μA
I _{GSS}	gate leakage current	$V_{GS} = 8 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	100	nA
		V_{GS} = -8 V; V_{DS} = 0 V; T_j = 25 °C	-	10	100	nA
R _{DSon}	drain-source on-state	V_{GS} = -2.5 V; I_D = -1 A; T_j = 25 °C	-	117	150	mΩ
	resistance	V_{GS} = -2.5 V; I_D = -1 A; T_j = 150 °C	-	175	230	mΩ
		V_{GS} = -1.8 V; I _D = -0.5 A; T _j = 25 °C	-	140	180	mΩ
		V_{GS} = -4.5 V; I_D = -1 A; T_j = 25 °C	-	80	120	mΩ
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$I_D = -1 \text{ A}; V_{DS} = -10 \text{ V}; V_{GS} = -4.5 \text{ V};$	-	7.2	-	nC
Q _{GS}	gate-source charge	$T_j = 25 \ ^{\circ}C$	-	1.7	-	nC
Q _{GD}	gate-drain charge		-	1.83	-	nC
C _{iss}	input capacitance	V_{DS} = -13 V; V_{GS} = 0 V; f = 1 MHz;	-	528	-	pF
C _{oss}	output capacitance	T _j = 25 °C	-	200	-	pF
C _{rss}	reverse transfer capacitance		-	57	-	pF
t _{d(on)}	turn-on delay time	V_{DS} = -10 V; R_L = 10 Ω ; V_{GS} = -8 V;	-	2	-	ns
t _r	rise time	$R_{G(ext)} = 6 \Omega; T_j = 25 \text{ °C}; I_D = -1 A$	-	4.5	-	ns
t _{d(off)}	turn-off delay time		-	45	-	ns
t _f	fall time		-	20	-	ns
g fs	transfer conductance	V_{DS} = -13 V; I_D = -1 A; T_j = 25 °C	1.5	4.5	-	S
Source-d	rain diode					
V _{SD}	source-drain voltage	I_{S} = -0.62 A; V_{GS} = 0 V; T_{j} = 25 °C	-	-0.62	-1.3	V
t _{rr}	reverse recovery time	$I_{S} = -0.5 \text{ A}; \text{ dI}_{S}/\text{dt} = -100 \text{ A}/\mu\text{s};$	-	75	-	ns
Q _r	recovered charge	$V_{GS} = 0 \text{ V}; V_{DS} = -12.8 \text{V}; \text{T}_{j} = 25 ^{\circ}\text{C}$	-	69	-	nC

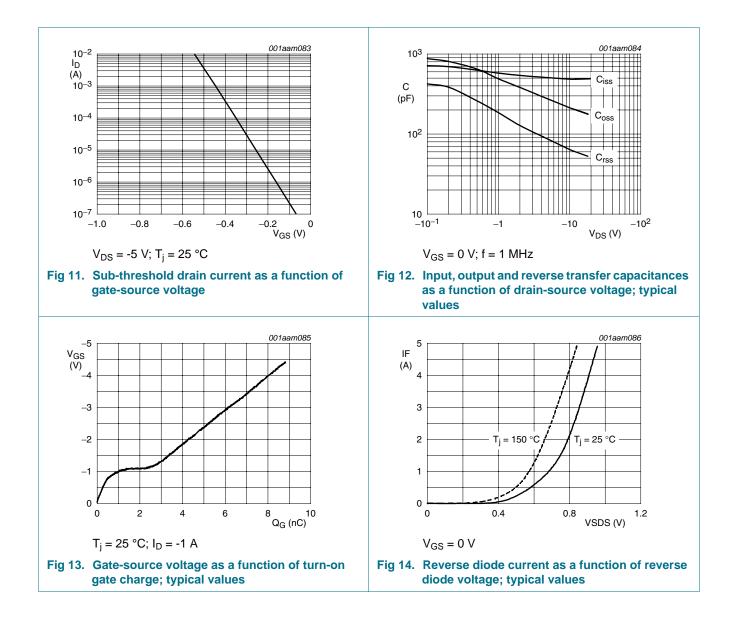
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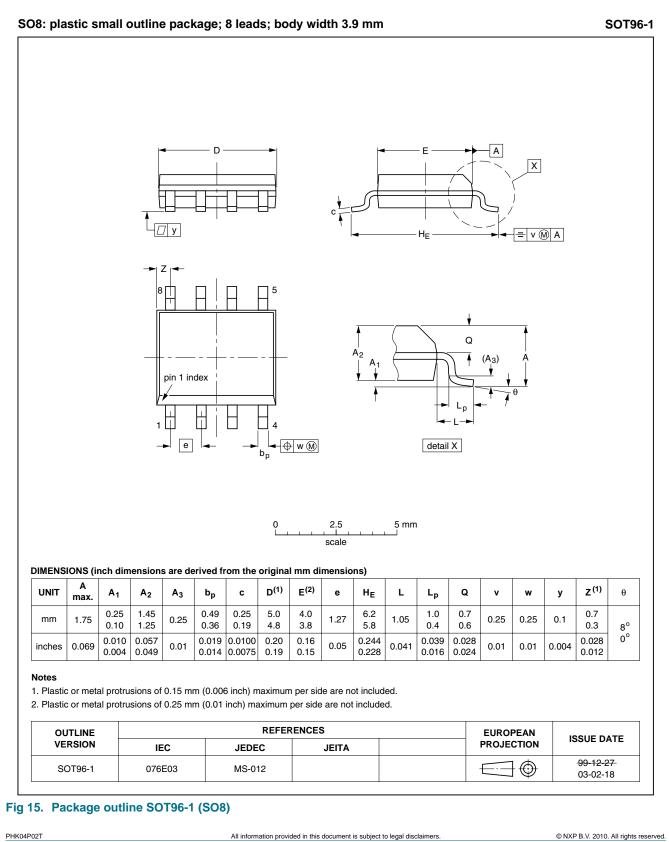
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Package outline 7.



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8. Revision history

Table 7. Revision	n history			
Document ID	Release date	Data sheet status	Change notice	Supersedes
PHK04P02T v.2	20101214	Product data sheet	-	PHK04P02T v.1
Modifications:	 The format of of NXP Semic 	this data sheet has been rec onductors.	designed to comply with	n the new identity guidelines
	 Legal texts hat 	ve been adapted to the new	company name where	appropriate.
PHK04P02T v.1	20020501	Product specification	-	-

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9. Legal information

9.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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Date of release: 14 December 2010 Document identifier: PHK04P02T

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